
**Statistical methods in process
management — Capability and
performance —**

**Part 3:
Machine performance studies for
measured data on discrete parts**

*Méthodes statistiques dans la gestion de processus — Aptitude et
performance —*

*Partie 3: Études de performance de machines pour des données
mesurées sur des parties discrètes*

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Foreword

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The main changes compared to the previous edition are as follows:

- updated and improved figures and computer outputs.

A list of all parts in the ISO 22514 series can be found on the ISO website.

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